

**Search Notes****Application/Control No.**

10/809,545

**Examiner**

Yonel Beaulieu

**Applicant(s)/Patent under Reexamination**

TANAKA ET AL.

**Art Unit**

3661

**SEARCHED**

Class	Subclass	Date	Examiner
701	36	11/4/2005	YB
	41		
180	199	11/4/2005	YB
	204		
	6.2		
280	762	11/4/2005	YB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST/Inventor's Name Search	11/5/2005	YB
	11/7/2005	YB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner